

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/650,198	COK ET AL.	
Examiner		Art Unit		Page 1 of 1
Uyen-Chau N. Le		2876		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,101,039 A	08-2000	Blazey, Richard N.	359/619
	B	US-6,174,400 B1	01-2001	Krutak et al.	428/32.6
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07266755 A	10-1995	Japan	ARAI et al.	B42D 15/10
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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